

## Product Summary

$BV_{DSS}$	$R_{DS(ON)} \text{ Max}$	$I_D$ $T_A = +25^\circ\text{C}$
30V	23m $\Omega$ @ $V_{GS} = 10\text{V}$	6.6A
	30m $\Omega$ @ $V_{GS} = 4.5\text{V}$	5.8A

## Description

This new generation MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ), yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

## Applications

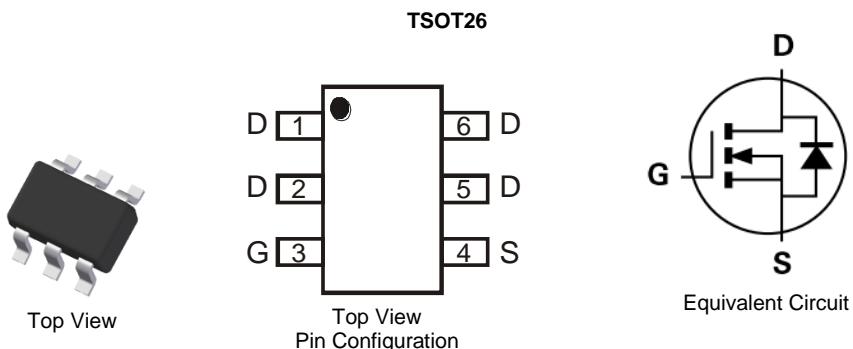
- DC-DC Converters
- Power management functions
- Backlighting

## Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)**
- Qualified to AEC-Q101 Standards for High Reliability**
- PPAP Capable (Note 4)**

## Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Tin Finish Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 **e3**
- Weight: 0.013 grams (Approximate)



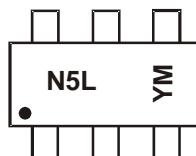
## Ordering Information (Note 5)

Part Number	Case	Packaging
DMN3026LVTQ-7	TSOT26	3,000/Tape & Reel
DMN3026LVTQ-13	TSOT26	10,000/Tape & Reel

Notes:

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to [http://www.diodes.com/quality/product\\_compliance\\_definitions/](http://www.diodes.com/quality/product_compliance_definitions/).
- For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



N5L = Product Type Marking Code  
 YM = Date Code Marking  
 Y = Year (ex: A = 2013)  
 M = Month (ex: 9 = September)

### Date Code Key

Year	2010	...	2014	2015	2016	2017	2018	2019	2020	2021	2022	
Code	X	...	B	C	D	E	F	G	H	I	J	
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

## Maximum Ratings (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Value	Units
Drain-Source Voltage	$V_{DSS}$	30	V
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Note 7) $V_{GS} = 10\text{V}$	Steady State	$I_D = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	$I_D$ 6.6 5.3
	$t < 10\text{s}$	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	$I_D$ 8.5 6.8
Maximum Body Diode Forward Current (Note 7)	$I_S$	3.0	A
Pulsed Drain Current (10 $\mu\text{s}$ pulse, duty cycle = 1%)	$I_{DM}$	35	A

## Thermal Characteristics

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 6)	$P_D$	1.2	W
		0.8	
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	100	$^\circ\text{C}/\text{W}$
		60	$^\circ\text{C}/\text{W}$
Total Power Dissipation (Note 7)	$P_D$	1.5	W
		1.0	
Thermal Resistance, Junction to Ambient (Note 7)	$R_{\theta JA}$	83	$^\circ\text{C}/\text{W}$
		50	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Case (Note 7)	$R_{\theta JC}$	14.5	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 8)</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	30	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}$ , $\text{I}_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$\text{I}_{\text{DSS}}$	—	—	1.0	$\mu\text{A}$	$\text{V}_{\text{DS}} = 30\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$
Gate-Source Leakage	$\text{I}_{\text{GSS}}$	—	—	$\pm 100$	nA	$\text{V}_{\text{GS}} = \pm 20\text{V}$ , $\text{V}_{\text{DS}} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 8)</b>						
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	1.0	1.5	2.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}$ , $\text{I}_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS(ON)}}$	—	19	23	$\text{m}\Omega$	$\text{V}_{\text{GS}} = 10\text{V}$ , $\text{I}_D = 6.5\text{A}$
		—	22	30		$\text{V}_{\text{GS}} = 4.5\text{V}$ , $\text{I}_D = 6.0\text{A}$
Diode Forward Voltage	$\text{V}_{\text{SD}}$	—	0.7	1.2	V	$\text{V}_{\text{GS}} = 0\text{V}$ , $\text{I}_S = 1.0\text{A}$
<b>DYNAMIC CHARACTERISTICS (Note 9)</b>						
Input Capacitance	$\text{C}_{\text{iss}}$	—	643	—	pF	$\text{V}_{\text{DS}} = 15\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	$\text{C}_{\text{oss}}$	—	65	—		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	—	49	—		
Gate Resistance	$\text{R}_G$	—	2.5	—	$\Omega$	$\text{V}_{\text{DS}} = 0\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$ , $f = 1.0\text{MHz}$
Total Gate Charge ( $\text{V}_{\text{GS}} = 4.5\text{V}$ )	$\text{Q}_g$	—	5.7	—	nC	$\text{V}_{\text{DS}} = 15\text{V}$ , $\text{I}_D = 4.0\text{A}$
Total Gate Charge ( $\text{V}_{\text{GS}} = 10\text{V}$ )	$\text{Q}_g$	—	12.5	—		
Gate-Source Charge	$\text{Q}_{\text{gs}}$	—	1.7	—		
Gate-Drain Charge	$\text{Q}_{\text{gd}}$	—	1.8	—		
Turn-On Delay Time	$\text{t}_{\text{D(on)}}$	—	2.2	—	nS	$\text{V}_{\text{GS}} = 10\text{V}$ , $\text{V}_{\text{DD}} = 15\text{V}$ , $\text{R}_G = 6.0\Omega$ , $\text{I}_D = 6.5\text{A}$
Turn-On Rise Time	$\text{t}_r$	—	2.5	—		
Turn-Off Delay Time	$\text{t}_{\text{D(off)}}$	—	12.1	—		
Turn-Off Fall Time	$\text{t}_f$	—	3.0	—		
Body Diode Reverse Recovery Time	$\text{t}_{\text{rr}}$	—	6.5	—	nS	$\text{I}_F = 6.5\text{A}$ , $\text{dI}/\text{dt} = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	$\text{Q}_{\text{rr}}$	—	1.7	—	nC	$\text{I}_F = 6.5\text{A}$ , $\text{dI}/\text{dt} = 100\text{A}/\mu\text{s}$

Notes: 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.

8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.

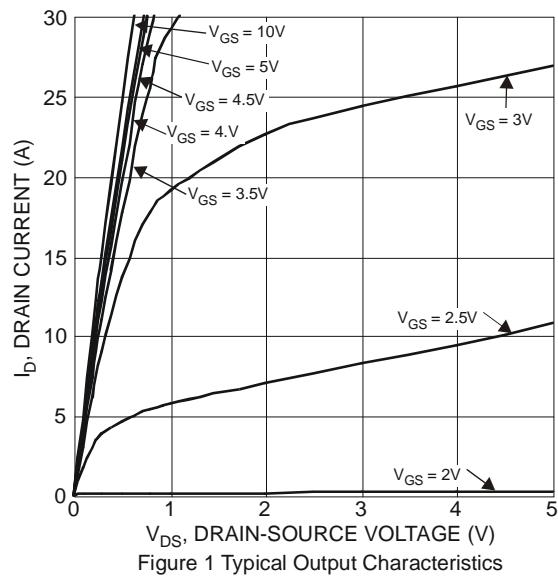


Figure 1 Typical Output Characteristics

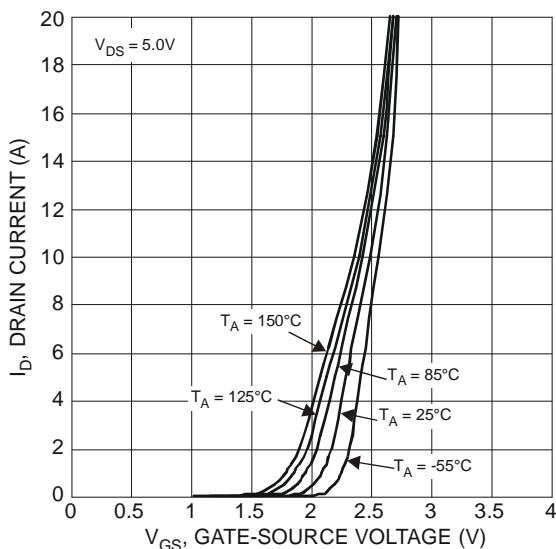


Figure 2 Typical Transfer Characteristics

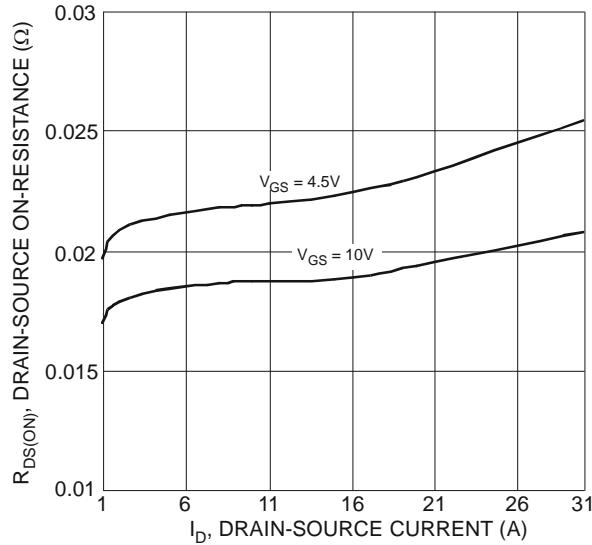


Figure 3 Typical On-Resistance vs.  
Drain Current and Gate Voltage

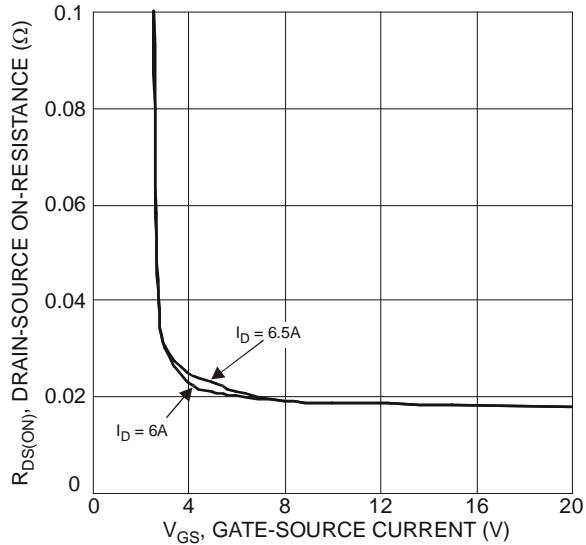


Figure 4 Typical Transfer Characteristics

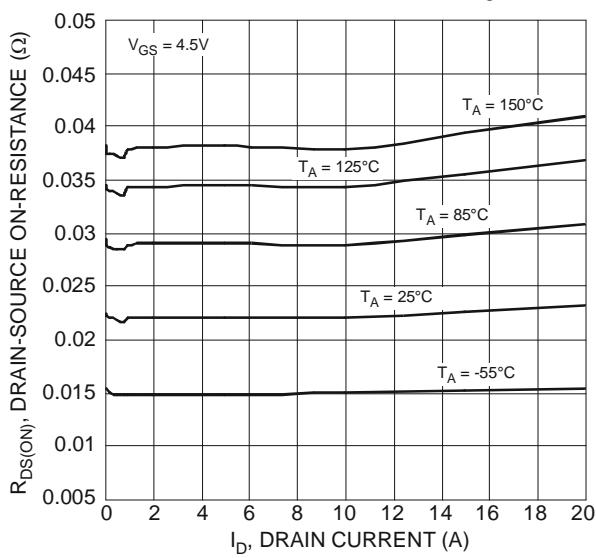


Figure 5 Typical On-Resistance vs.  
Drain Current and Temperature

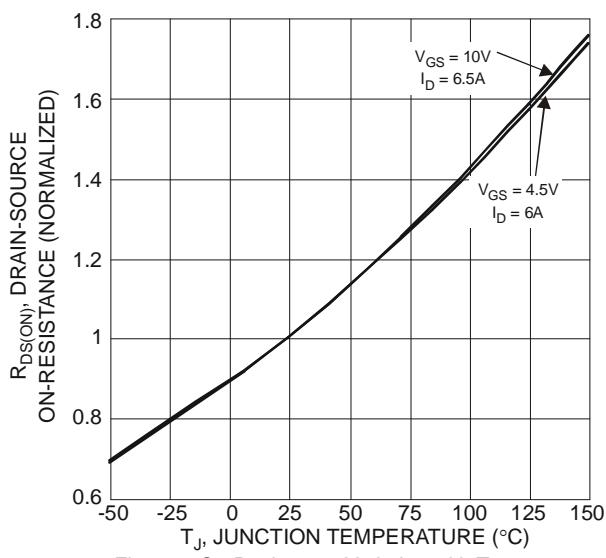


Figure 6 On-Resistance Variation with Temperature

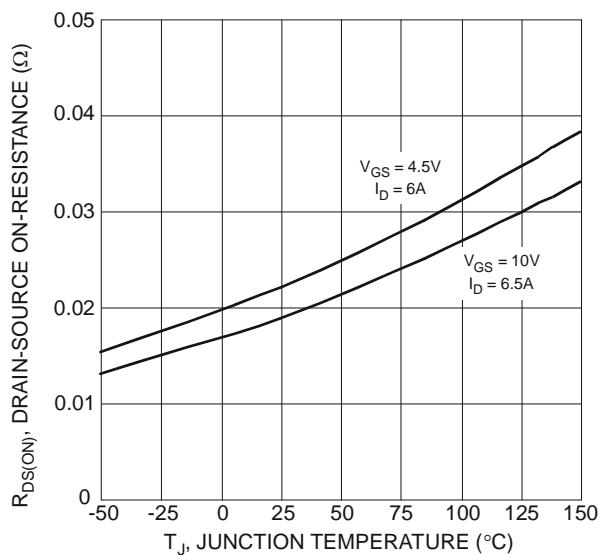


Figure 7 On-Resistance Variation with Temperature

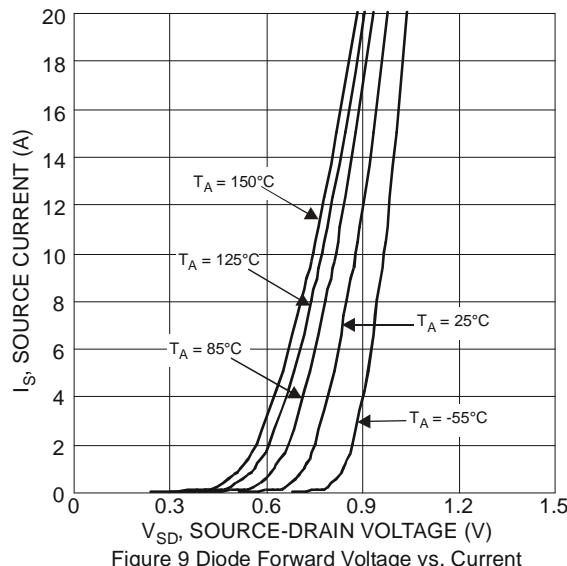


Figure 9 Diode Forward Voltage vs. Current

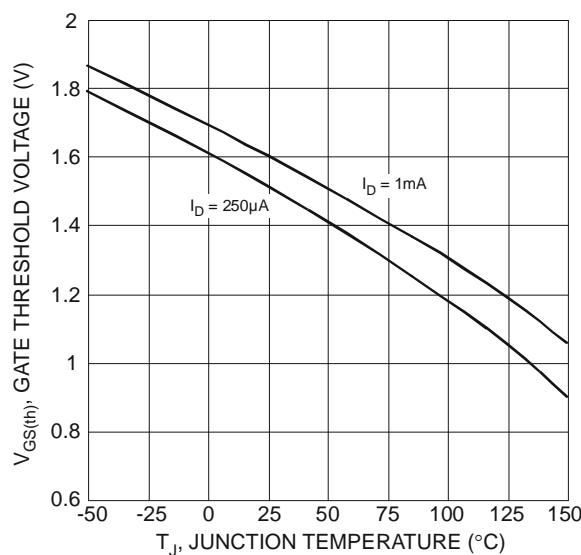


Figure 8 Gate Threshold Variation vs. Ambient Temperature

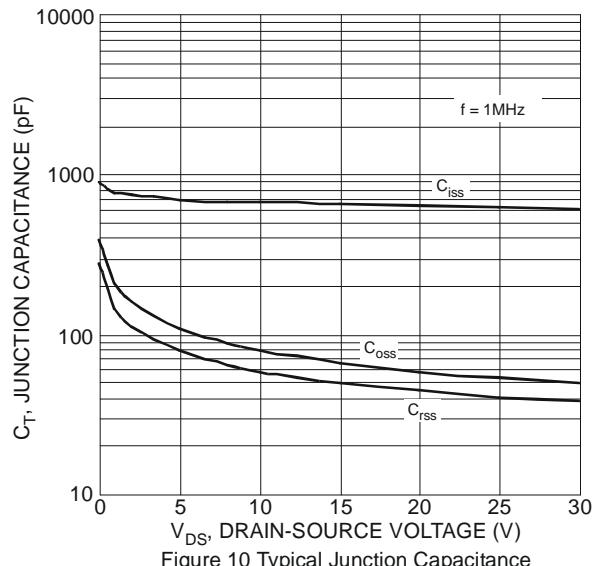


Figure 10 Typical Junction Capacitance

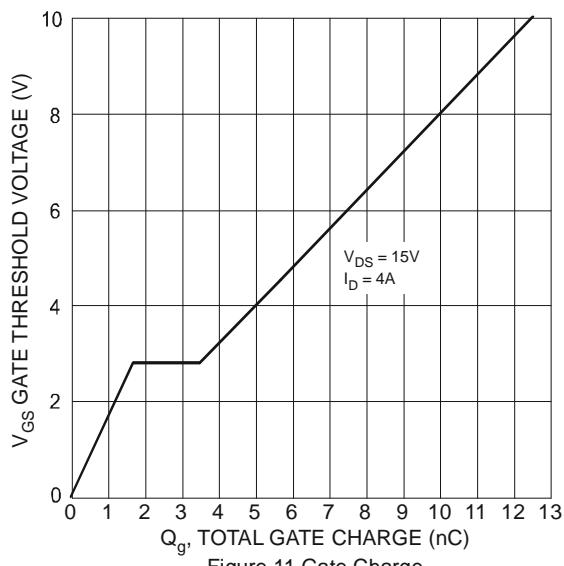


Figure 11 Gate Charge

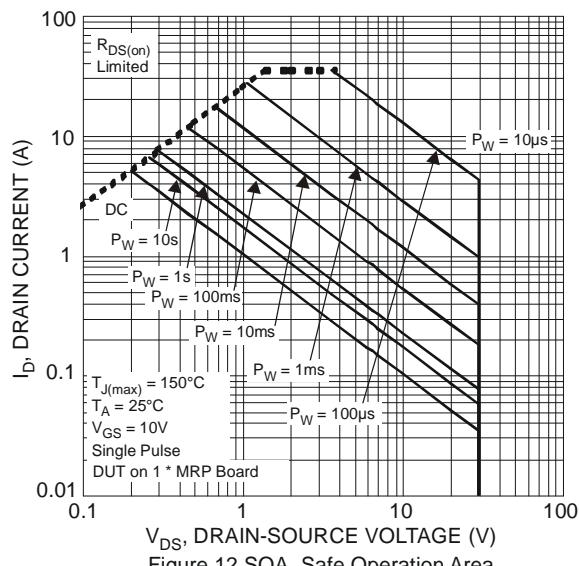


Figure 12 SOA, Safe Operation Area

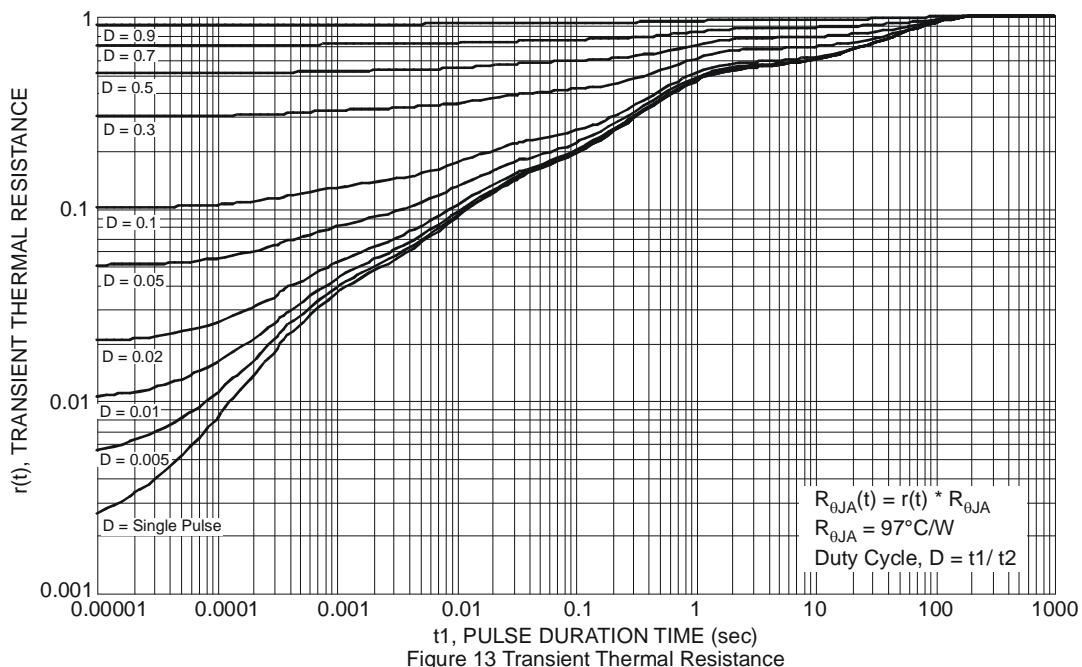
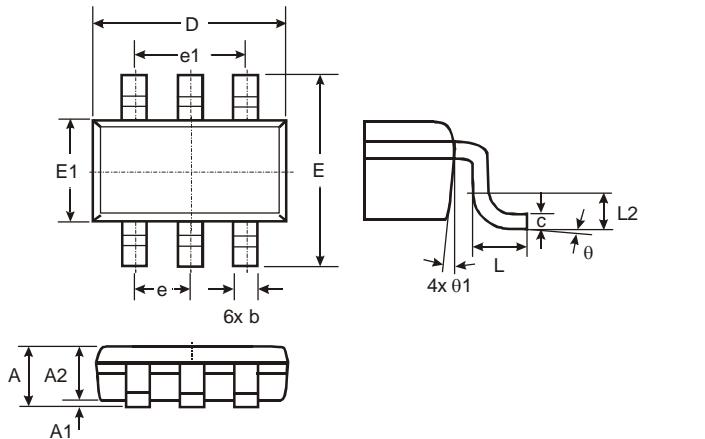


Figure 13 Transient Thermal Resistance

## Package Outline Dimensions

Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for the latest version.

TSOT26



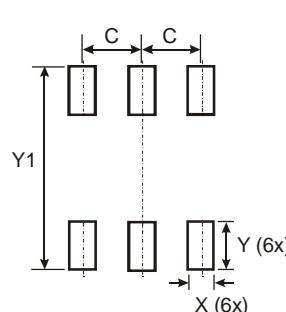
TSOT26			
Dim	Min	Max	Typ
<b>A</b>	—	1.00	—
<b>A1</b>	0.01	0.10	—
<b>A2</b>	0.84	0.90	—
<b>D</b>	—	—	2.90
<b>E</b>	—	—	2.80
<b>E1</b>	—	—	1.60
<b>b</b>	0.30	0.45	—
<b>c</b>	0.12	0.20	—
<b>e</b>	—	—	0.95
<b>e1</b>	—	—	1.90
<b>L</b>	0.30	0.50	—
<b>L2</b>	—	—	0.25
<b>θ</b>	0°	8°	4°
<b>θ1</b>	4°	12°	—

All Dimensions in mm

## Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.

TSOT26



Dimensions	Value (in mm)
<b>C</b>	0.950
<b>X</b>	0.700
<b>Y</b>	1.000
<b>Y1</b>	3.199

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